

RoHS COMPLIANT

DMP3010LPS-13-VB Datasheet

P-Channel 30-V (D-S) MOSFET

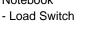
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
- 30	0.004 at V _{GS} = - 10 V	- 120	130 nC		
	0.006 at V _{GS} = - 4.5 V	- 100	130 110		

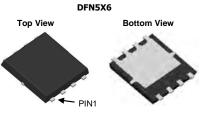
FEATURES

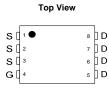
- Halogen-free
- Trench Power MOSFET
- 100 % Rg Tested

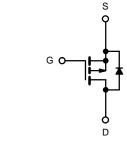
APPLICATIONS

Notebook









P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 30	V	
Gate-Source Voltage	V _{GS}	± 20	v	
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$ $T_{A} = 70 °C$	I _D	- 120 ^a - 100 ^a - 31.6 ^{b, c} - 25.3 ^{b, c}	
Pulsed Drain Current		I _{DM}	- 280	— A
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	- 80 ^a - 56 ^{b, c}	
Single Pulse Avalanche Current	che Current		- 60	
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	160	mJ
Maximum Power Dissipation	$T_{C} = 25 \text{ °C}$ $T_{C} = 70 \text{ °C}$ $T_{A} = 25 \text{ °C}$ $T_{A} = 70 \text{ °C}$	P _D	110 83 6.95 ^{b, c} 5.0 ^{b, c}	W
Operating Junction and Storage Temperature Rar	T _J , T _{stg}	- 55 to 150	<u></u>	
Soldering Recommendations (Peak Temperature)	-	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	15	20	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2	0/11	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed

copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 54 °C/W.

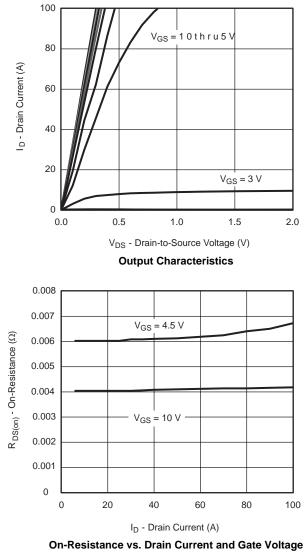


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 250 μA		6.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
		$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 10	- μΑ	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 30			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 20 A		0.004		Ω	
		V _{GS} = - 4.5 V, I _D = - 15 A		0.006			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 20 A		97		S	
Dynamic ^b				1	<u> </u>	<u> </u>	
Input Capacitance	C _{iss}			7050		pF	
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		1375			
Reverse Transfer Capacitance	C _{rss}			1215			
Total Gate Charge		V_{DS} = - 15 V, V_{GS} = - 10 V, I_{D} = - 20 A		130	250	- nC	
				78	130		
Gate-Source Charge	Q _{gs}	V_{DS} = - 15 V, V_{GS} = - 4.5 V, I_{D} = - 20 A		29			
Gate-Drain Charge	Q _{gd}			37			
Gate Resistance	Rg	f = 1 MHz		1.9		Ω	
Turn-On Delay Time	t _{d(on)}			25	40	ns	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		15	30		
Turn-Off Delay Time	t _{d(off)}	$I_{D}\cong$ - 1.0 A, V_{GEN} = - 10 V, R_{g} = 1 Ω		110	170		
Fall Time	t _f			30	50		
Turn-On Delay Time	t _{d(on)}			110	170		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 15 Ω		100	150		
Turn-Off Delay Time	t _{d(off)}	$\rm I_D \cong$ - 1.0 A, $\rm V_{GEN}$ = - 4.5 V, $\rm R_g$ = 1 Ω		100	150		
Fall Time	t _f			50	75		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			100	A	
Pulse Diode Forward Current ^a	I _{SM}				120		
Body Diode Voltage	V _{SD}	I _S = - 5 A		- 0.54	- 1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			50	100	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			65	130	nC	
Reverse Recovery Fall Time	t _a	l _F = 3.5 A, dl/dt = 100 A/μs, T _J = 25 °C		26			
Reverse Recovery Rise Time	t _b	\neg		24		ns	

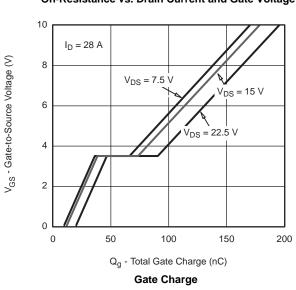
Notes:

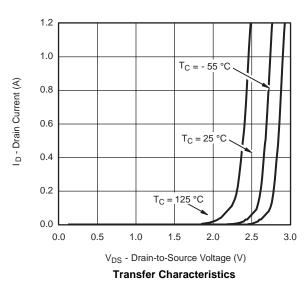
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

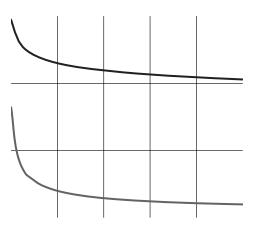
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



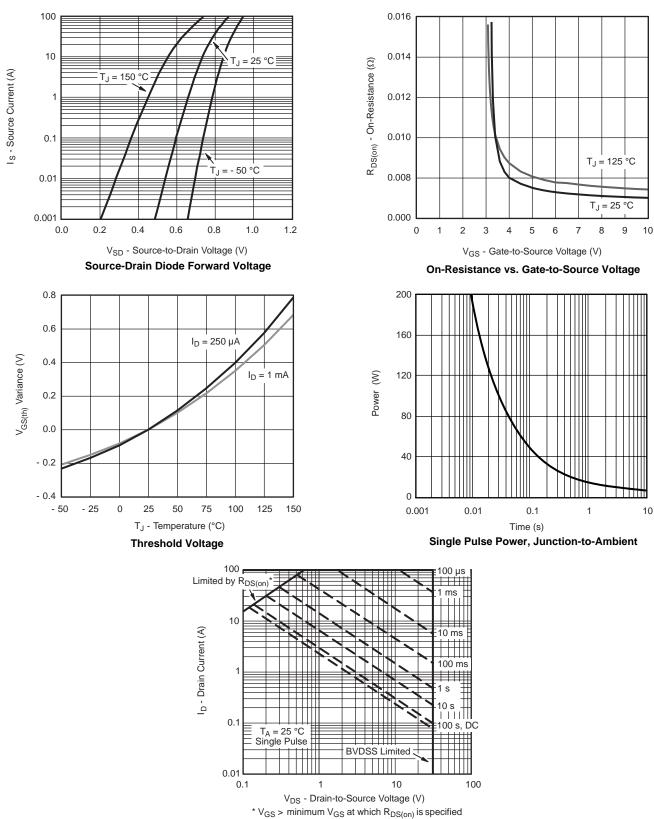




Capacitance

On-Resistance vs. Junction Temperature





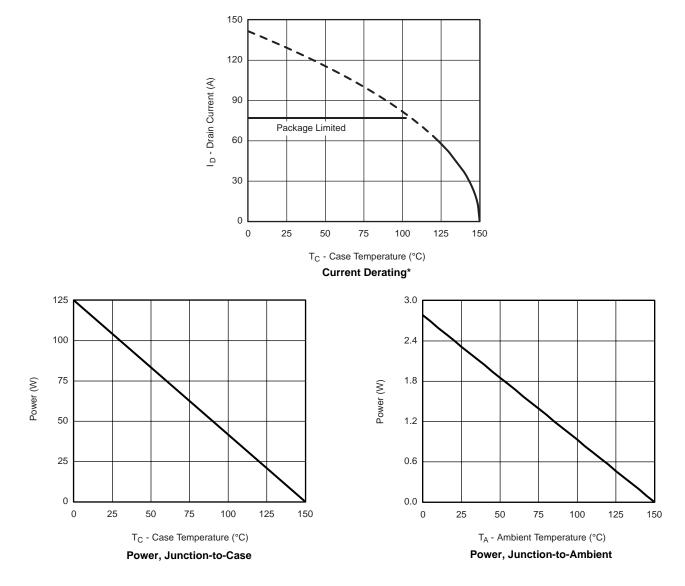
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

服务热线:400-655-8788

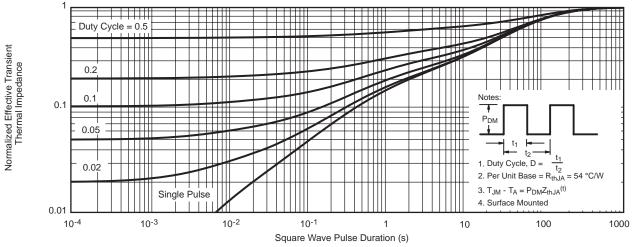


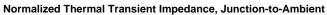
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

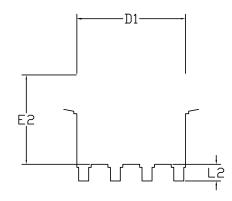
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

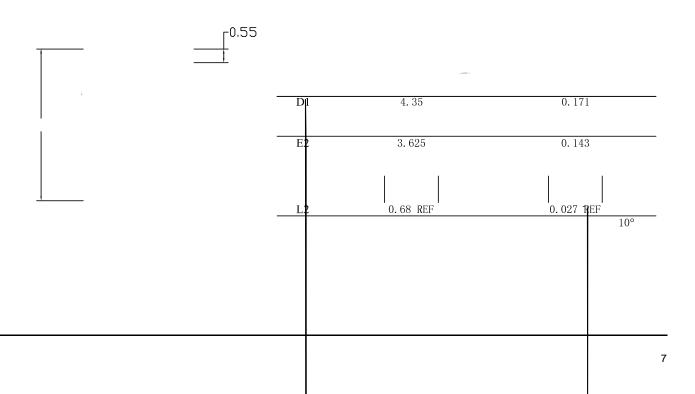






Normalized Thermal Transient Impedance, Junction-to-Case







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